T10/04-195r4 SAS-1.1 Internal Wide Connector/Cable Electrical Requirements

To: T10 Technical Committee
From: Barry Olawsky, HP (barry.olawsky@hp.com)
Date: 26 August 2004
Subject: T10/04-195r4 SAS-1.1 Internal Wide Connector/Cable Electrical Requirements

Revision History
Revision 0 (1 July 2004) first revision
Revision 1 (8 July 2004) Changed note “f” to clarify frequency range. Changed note “g” from must to shall.
Revision 2 (2 August 2004) Specified tolerance of TDR rise time by changing value to an absolute maximum. Clarified note “a” on TDR setup.
Revision 3 (24 August 2004) Removed “equivalent” time category in table. Reference will remain in note section.
Revision 4 (26 August 2004) Changed decibels abbreviation from “db” to “dB”. Changed two instances of the word “suggested” to “proposed”. Changed note introducing crosstalk data from “Supporting Information Only” to “Supporting Information Only (NOT part of SAS-1.1 proposal)”. Remove last sentence of note a (from 04-195r3) and replace with “When configuring software or hardware filters of the time domain reflectometer scope to obtain the equivalent rise time, filtering effects of test cables and test fixturing shall be included”. Replace acronym “TDR” with “Time domain reflectometer”.

Related Documents
sas1r05 - Serial Attached SCSI 1.1 revision 5
03-240r1 - SAS-1.1 Internal wide connector and cable (Rob Elliott, Hewlett Packard)
sff-8484r0.5 - Multi lane internal serial attachment connector (Brian Miller, Amphenol)
04-182r0 SAS-1.1 Internal wide connector/cable proposal feasibility study (Barry Olawsky, Hewlett Packard)

Overview
Propose electrical design/test requirements for internal wide connector/cable solution. Data in support of crosstalk specifications is included after suggested proposed changes.

Suggested Proposed Changes
Change paragraph number 5.3.9 title from “Impedance Specifications” to “Impedance and Media Specifications”.

Add the following table to section after impedance requirements table.

<table>
<thead>
<tr>
<th>Requirement</th>
<th>Units</th>
<th>1.5 Gbps</th>
<th>3.0 Gbps</th>
</tr>
</thead>
<tbody>
<tr>
<td>Equivalent</td>
<td>Time domain reflectometer rise time 20 % to 80 %</td>
<td>ps</td>
<td>70 (max)</td>
</tr>
<tr>
<td>Media (PCB or cable)</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Differential impedance</td>
<td>ohm</td>
<td>100 ± 10</td>
<td>100 ± 10</td>
</tr>
<tr>
<td>Differential impedance imbalance</td>
<td>ohm</td>
<td>5</td>
<td>5</td>
</tr>
<tr>
<td>Common mode impedance</td>
<td>ohm</td>
<td>32,5 ± 7,5</td>
<td>32,5 ± 7,5</td>
</tr>
<tr>
<td>Mated connectors</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Differential impedance</td>
<td>ohm</td>
<td>100 ± 15</td>
<td>100 ± 15</td>
</tr>
<tr>
<td>Mated Cable Assembly</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Maximum Insertion Loss</td>
<td>dBd</td>
<td>6</td>
<td>6</td>
</tr>
<tr>
<td>Maximum Near-End Crosstalk (adjacent pairs)</td>
<td>dBd</td>
<td>33</td>
<td>33</td>
</tr>
<tr>
<td>Maximum Near-End Crosstalk (between pairs differential signal pairs 1, 2, 3 and 4)</td>
<td>dBd</td>
<td>45</td>
<td>45</td>
</tr>
</tbody>
</table>
Maximum Near-End Crosstalk (between differential signal pairs 5, 6, 7 and 8) b, f, g dB 45 45
Maximum Near-End Crosstalk (all other differential signal pair combinations) b, f, g dB 50 50
Maximum Intra-Pair Skew b ps 10 10

a All times indicated for time domain reflectometer measurements are recorded times. Recorded times are twice the transit time of the time domain reflectometer signal. Filtering may be used to obtain the equivalent rise time. The filter consists of the two-way launch/return path of the test fixturing, two-way launch/return path of the test cable, and the software or hardware filtering of the TDR time domain reflectometer scope. The equivalent rise time is the rise time of the TDR time domain reflectometer scope output after application of all filter components. Filtering effects of test cables and fixturing shall be considered when configuring instrumentation to obtain the equivalent rise time. When configuring software or hardware filters of the time domain reflectometer scope to obtain the equivalent rise time, filtering effects of test cables and test fixturing shall be included.

b All measurements are made through mated connector pairs.

c The media impedance measurement identifies the impedance mismatches present in the media when terminated in its characteristic impedance. This measurement excludes mated connectors at both ends of the media, when present, but includes any intermediate connectors or splices. The mated connectors measurement applies only to the mated connector pair at each end, as applicable.

d Where the media has an electrical length of > 4 ns the procedure detailed in SFF-8410, or an equivalent procedure, shall be used to determine the impedance.

f The range for this frequency domain measurement is 10 MHz to 4500 MHz.

g The far end of the mated cable assembly must be terminated in its characteristic impedance. Insertion loss variations (i.e. cable length) may change the measurement result.

Supporting Information Only (NOT part of SAS-1.1 proposal):

Various cable samples from different suppliers were randomly selected and the tests performed with various differential signal pairs. Plots with higher crosstalk peaks are combined to understand how existing product compares to the proposed crosstalk levels. The following data is clearly NOT a statistical sample of product available.

Adjacent pairs are RX0/TX0, TX0/RX1, RX1/TX1, RX2/TX2, TX2/RX3, RX3/TX3.
Even pair crosstalk is between RX0/RX1, TX0/TX1, RX2/RX3, TX2/TX3. The results are similar for odd pairs.

End-to-end crosstalk is between any pair of the group RX0, TX0, RX1, TX1 to any pair of the group RX2, TX2, RX3, TX3. In this case, the crosstalk spans the section of the connector reserved for sidebands.